

# Finding the distribution of wake field induced losses in diagnostics structures for realistic machine conditions

Using time domain simulation and combined domain analysis in order to find the loss distribution in structures.

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Diamond light source



# Why are we worried?

- In some of our diagnostic structures the wake loss factor is large enough to give uncomfortably large amounts of energy being lost from the beam.
- Current settings imply  $\sim 125\text{W}$  lost from the beam at the striplines.
- We have broken a 50W load on a stripline.



- **Dissipated into the structure**
- **Transmitted down the beam pipe**
- **Transmitted out of measurement ports**

We use an **EM simulation** to distinguish between these conditions

Good for getting a quick idea of what proportion of energy stays in the structure

# Our approach

**Time domain EM simulation**  
Excite with bunch  
Record wake potential  
and port mode signals

Wake potential

Port signals

Combine charge  
distribution with  
wake potential

Integrate over  
time and sum over  
ports and modes

Energy lost from beam

Energy lost into ports

Difference is energy  
left in structure

Repeat as needed

## 2 stipulations

- The mesh must be fine enough to have stable results.
- The simulation must have run long enough for the majority of energy to have left the structure.

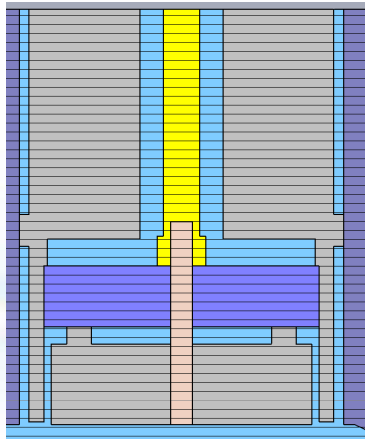
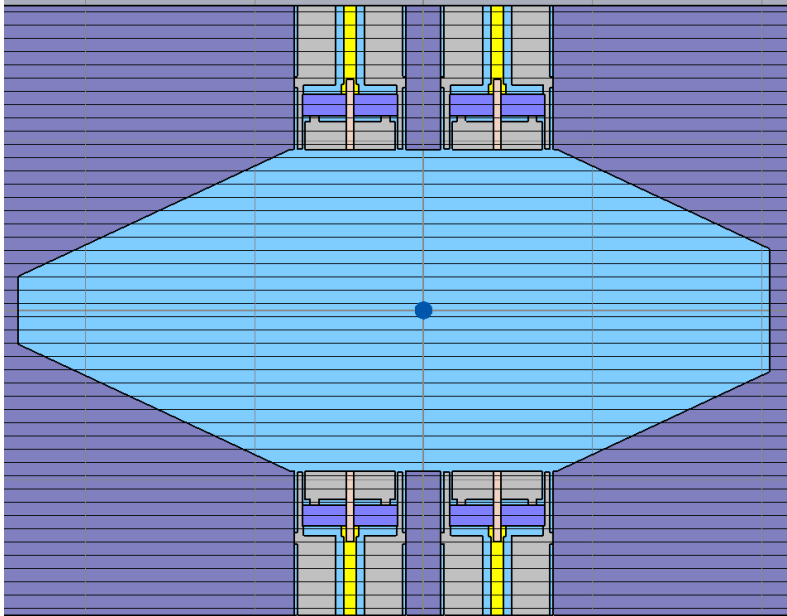


We use both **time** and **frequency** domain analysis to check for model stabilisation and for unphysical results.

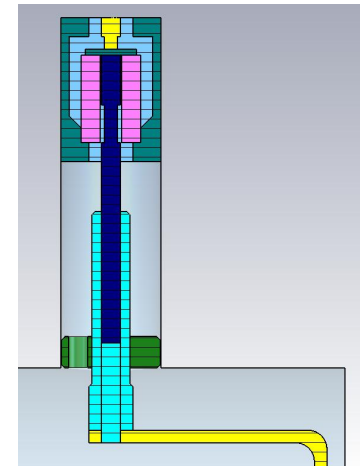
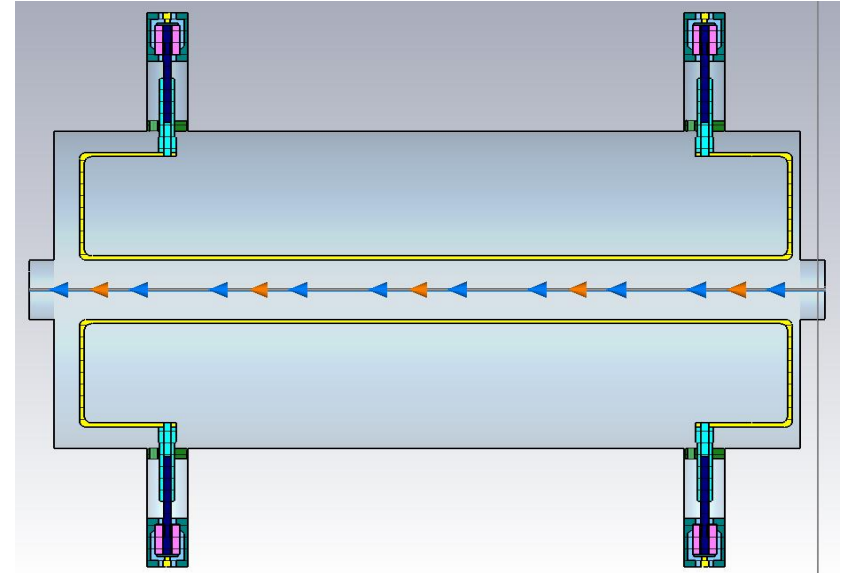
- Do the energy / wake potential / port signals decay over time?
- Is more energy emitted from the structure than was lost from the beam?
- Are the Qs stable?

Doing the analysis in both domains also allows for valuable cross checking of the analysis code.

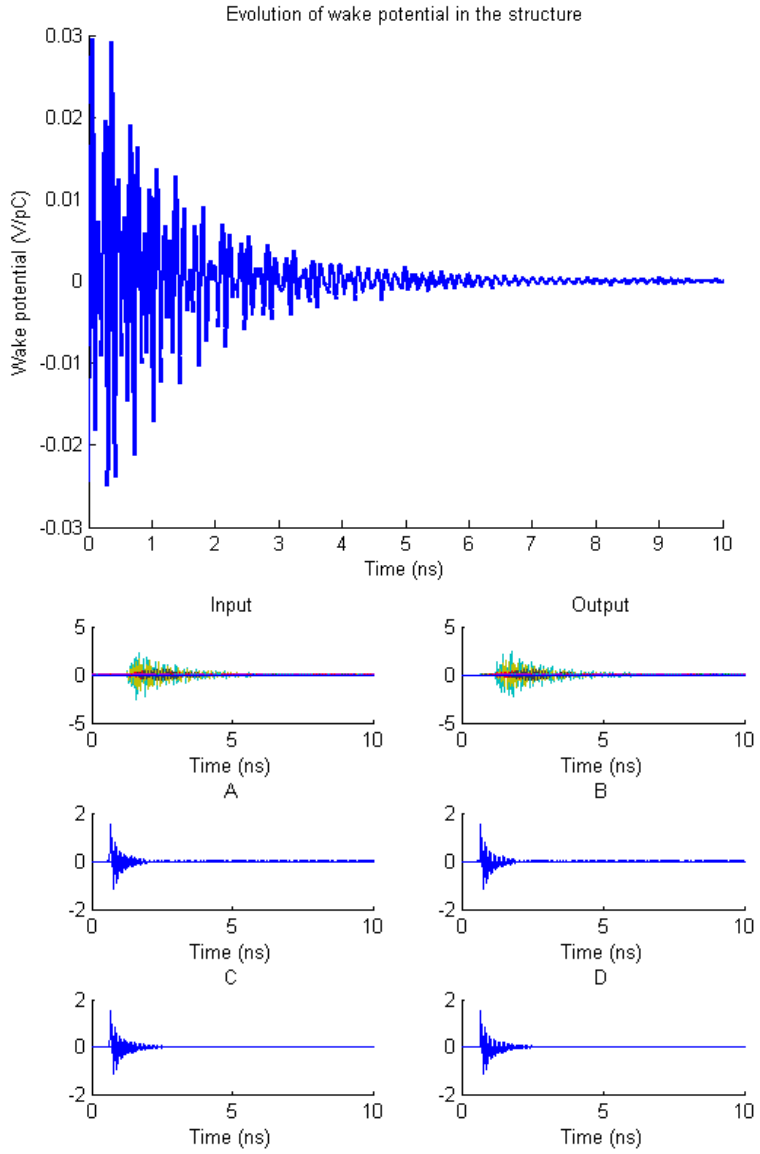
## Example: BPM



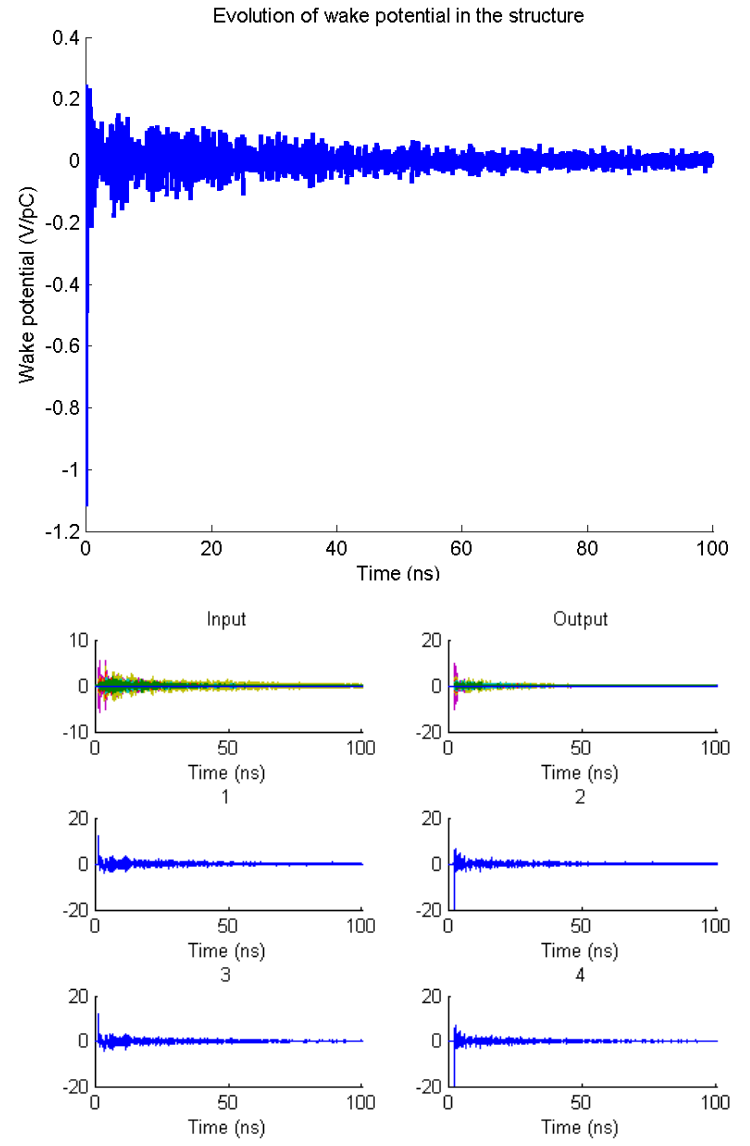
## Example: Stripline



### Example: BPM

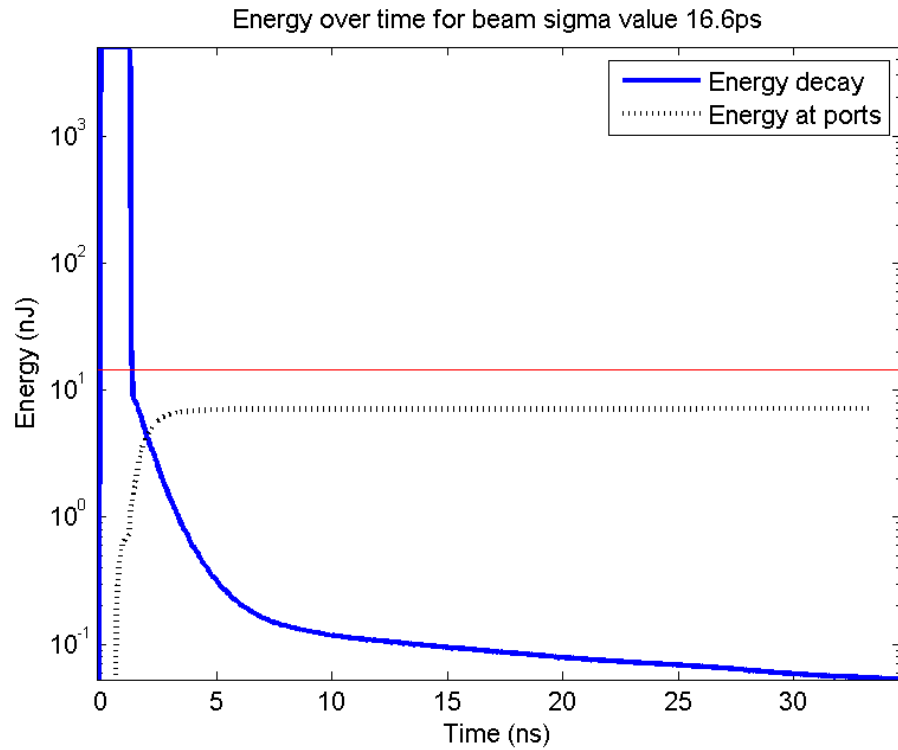


### Example: Striplines

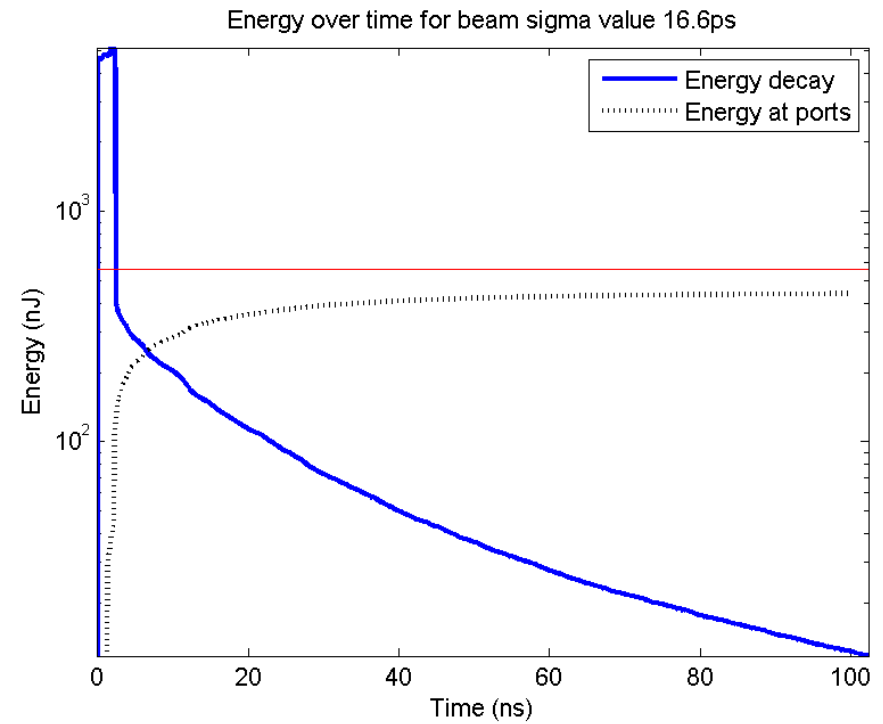


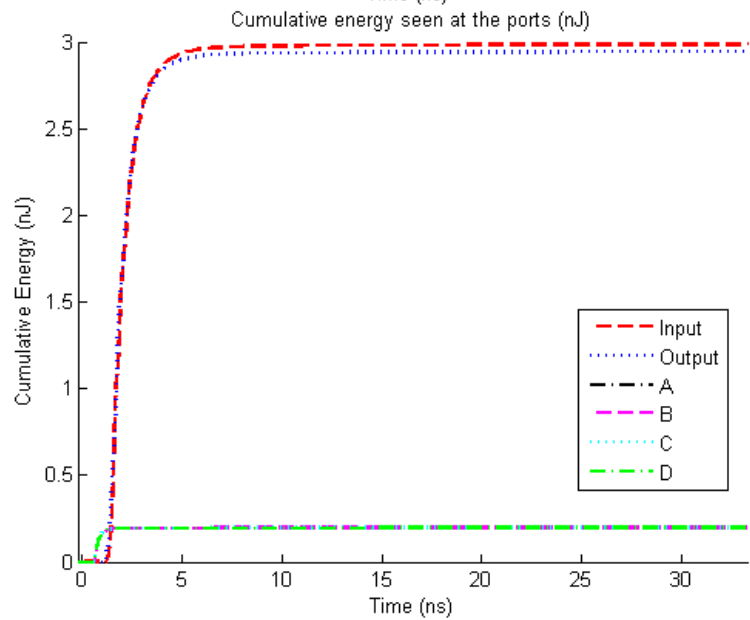
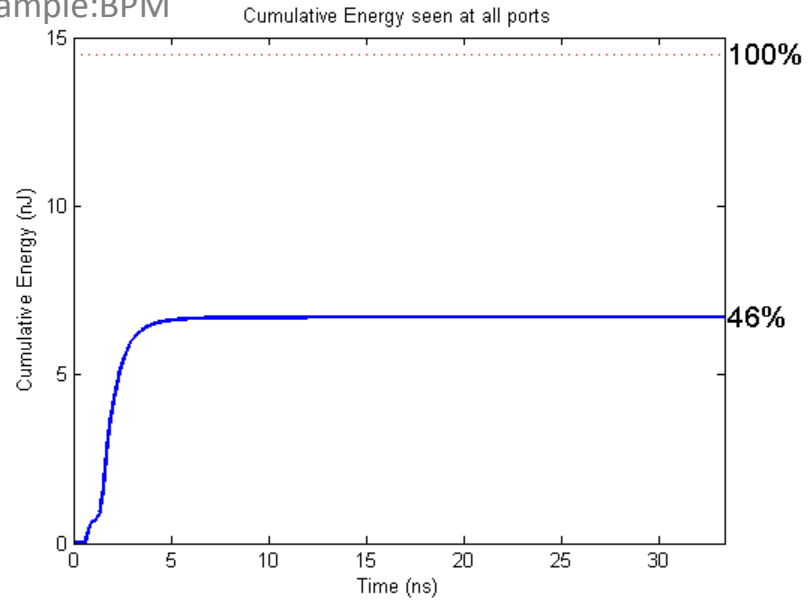
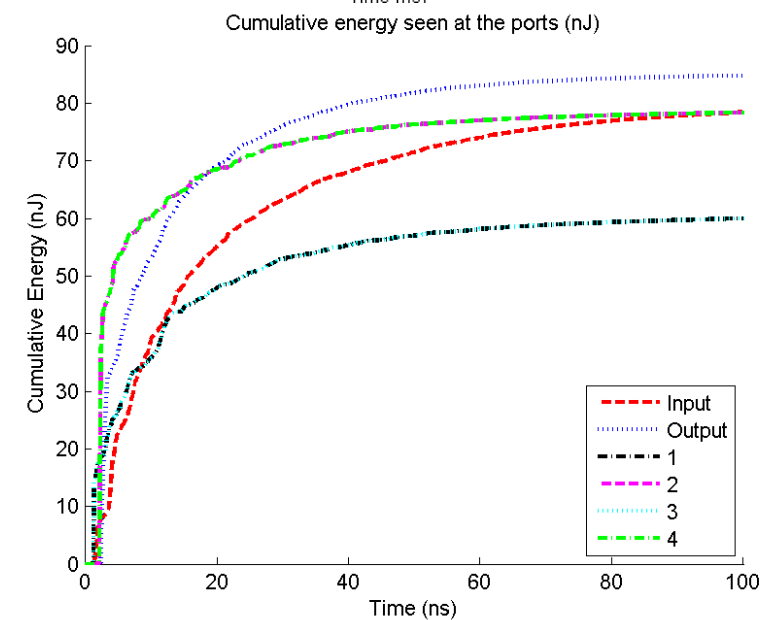
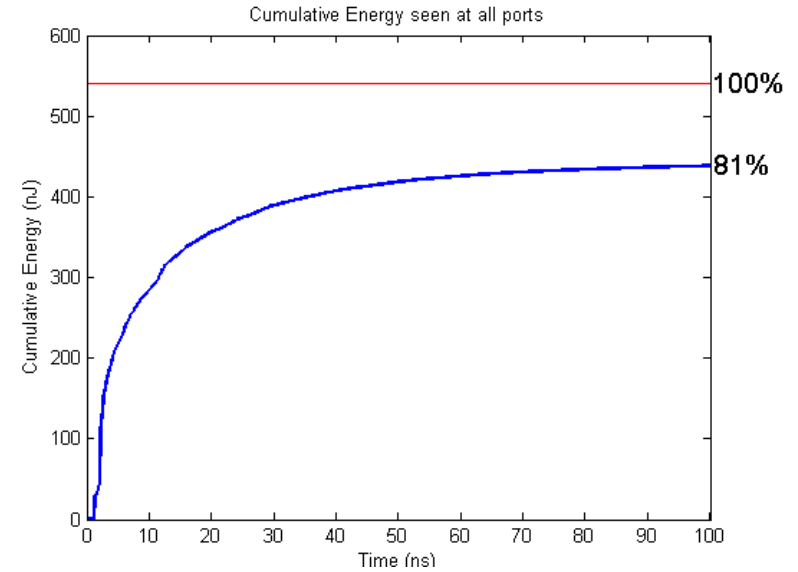


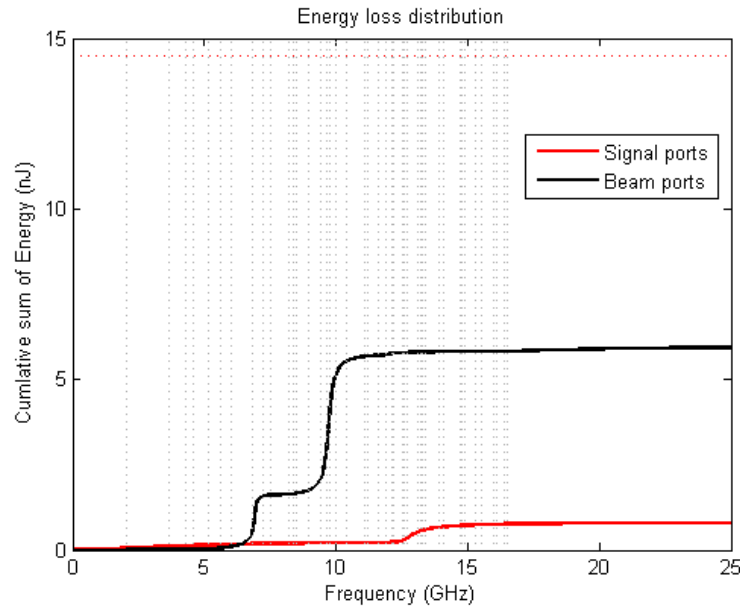
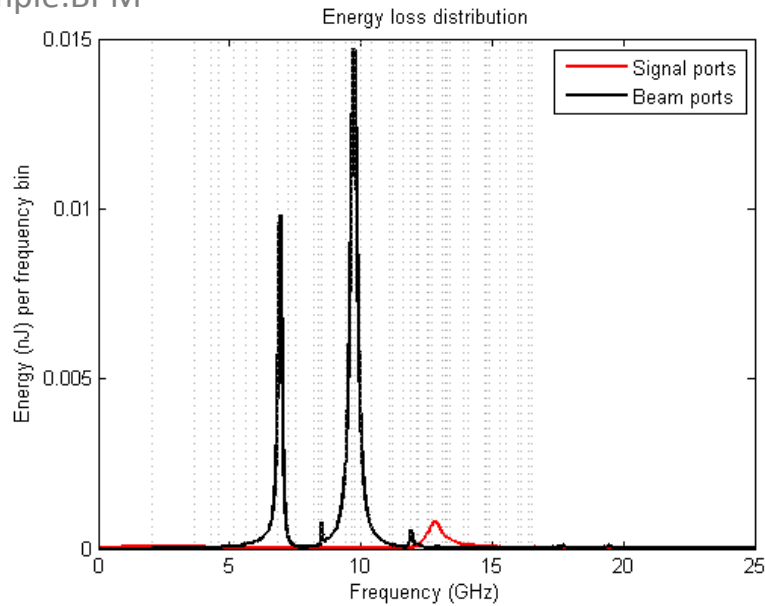
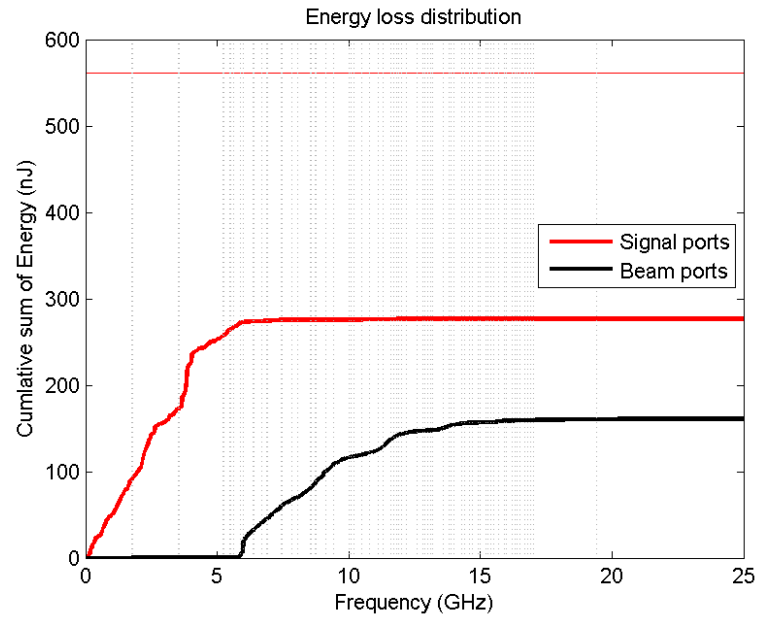
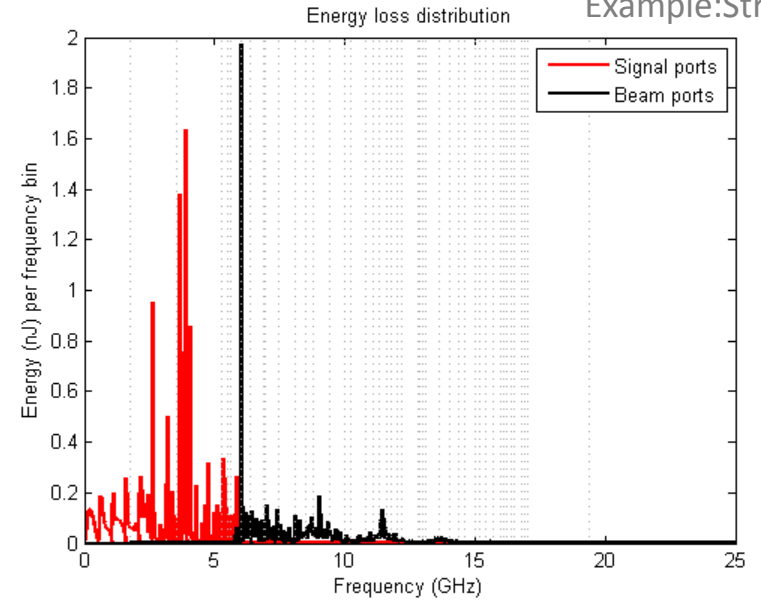
## Example: BPM



## Example: Striplines

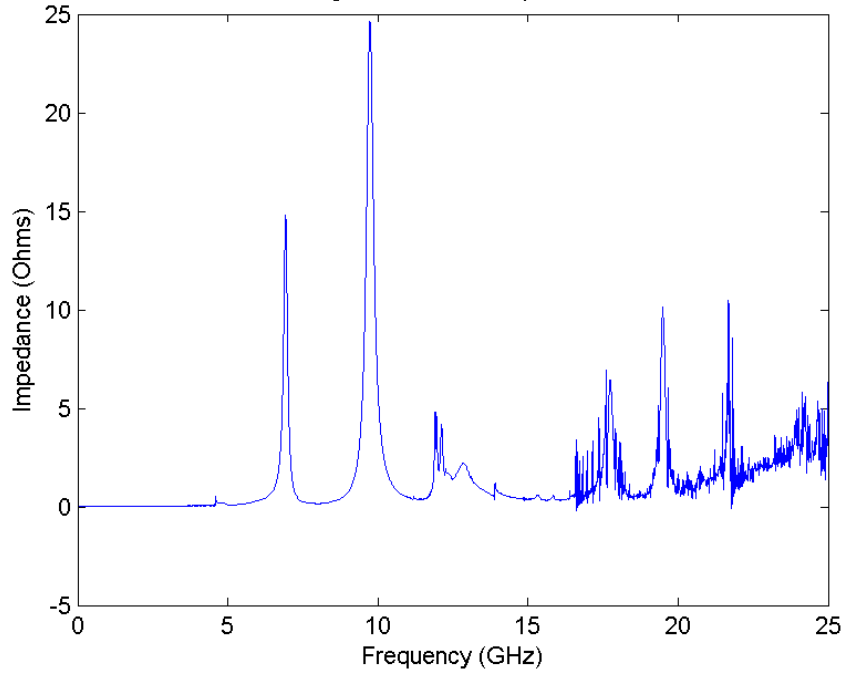


**Example: BPM**

**Example: Striplines**


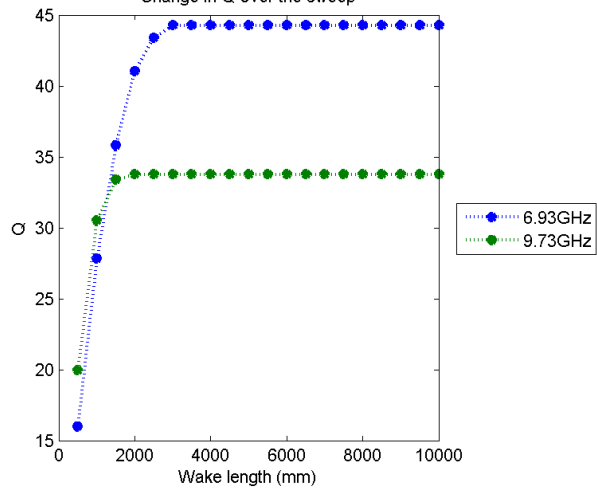
**Example: BPM**

**Example: Striplines**


**Example: BPM**

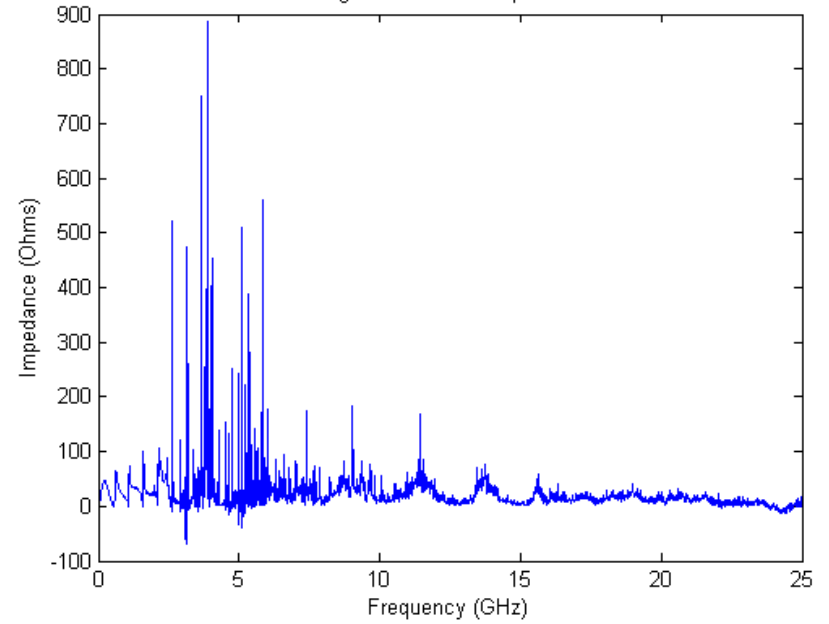
Longitudinal wake impedance



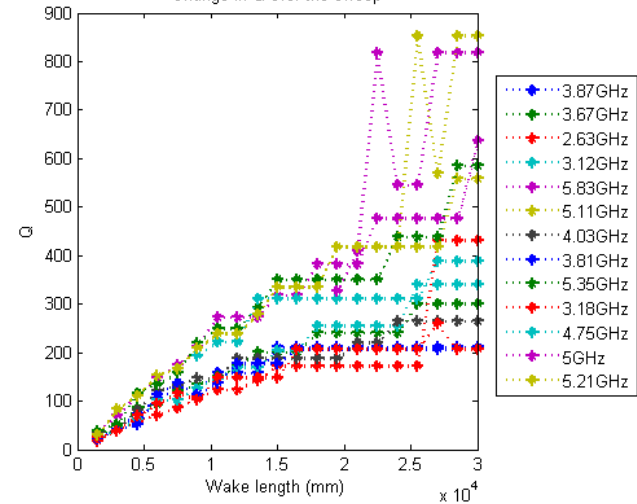
Change in Q over the sweep


**Example: Striplines**

Longitudinal wake impedance



Change in Q over the sweep



## So far:

we can get to a point of trusting that a model is a good representation.

we can find out how much energy is deposited into the structure by a single bunch.

**That is not the question we want answered.**

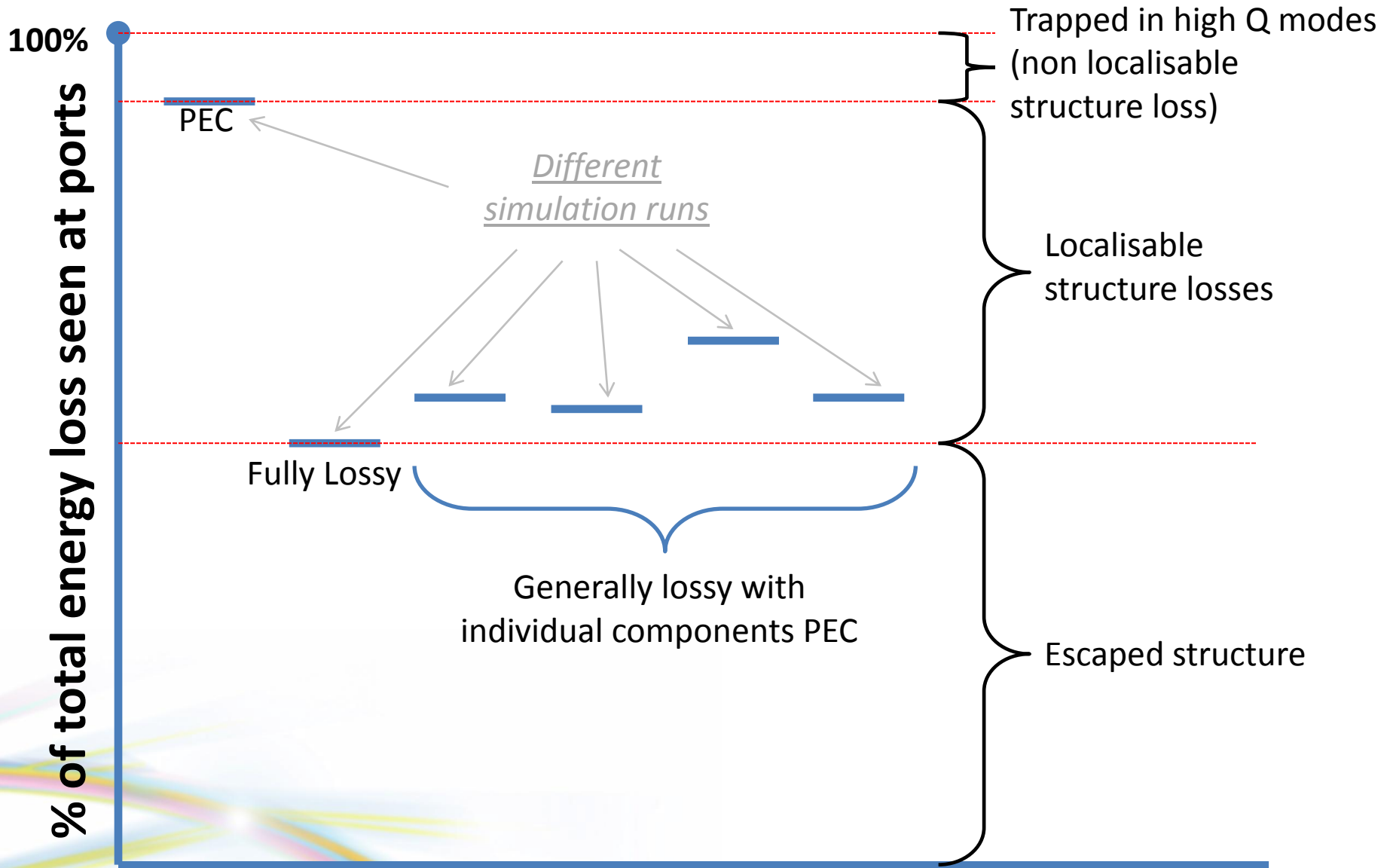
## We want to know:

Under normal operating conditions where within the structure does the energy go?

Requires an  
extension to the  
analysis

Requires more  
simulations

# One structure... many simulations



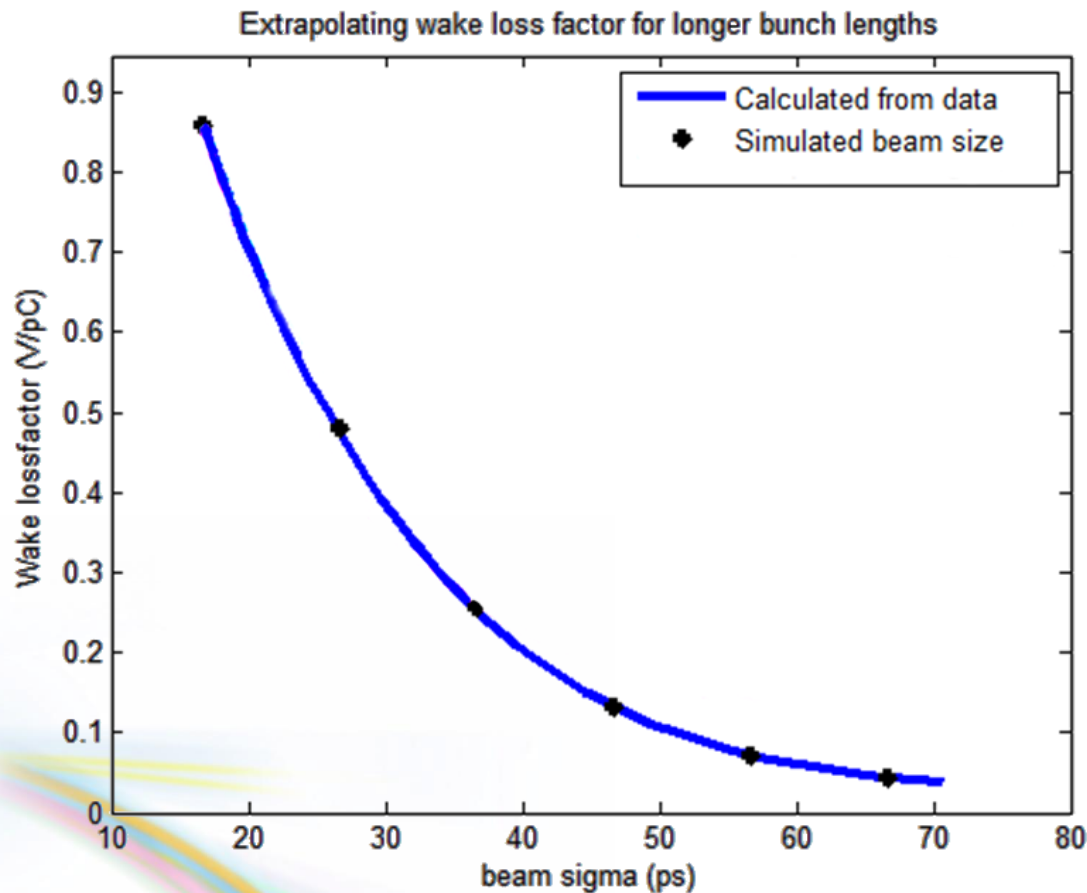
## Different model settings

We have the wake impedance which is the response of the structure **only**.

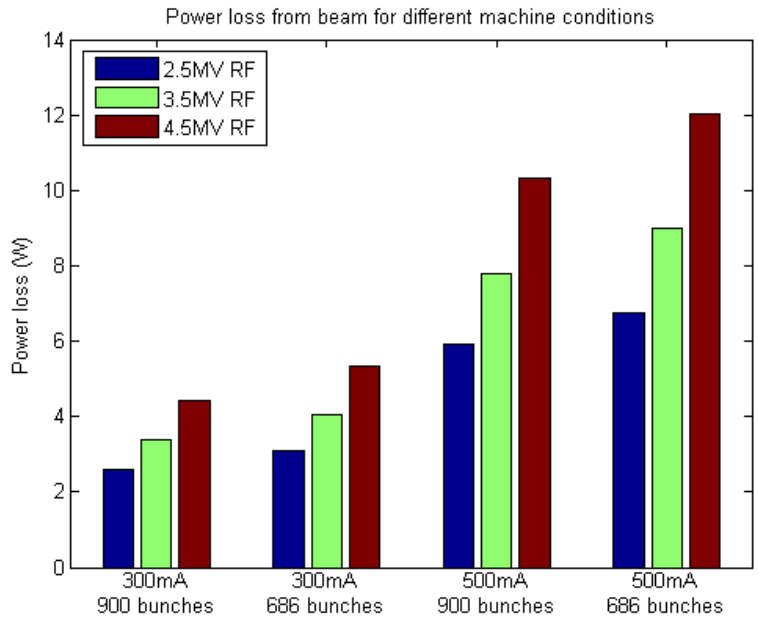
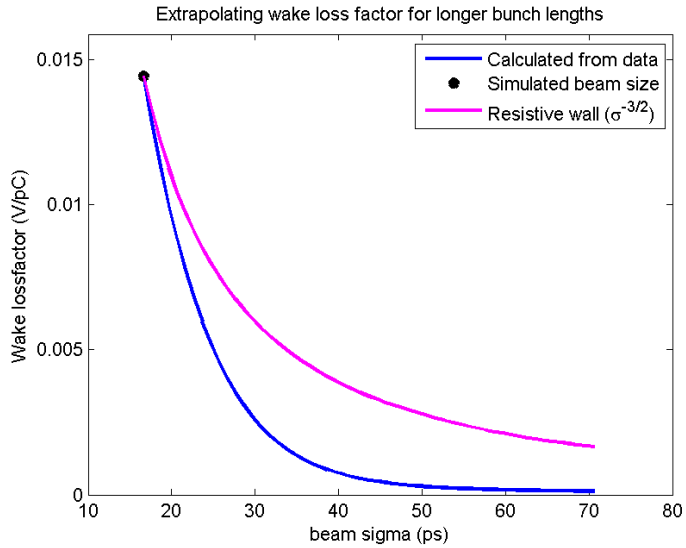
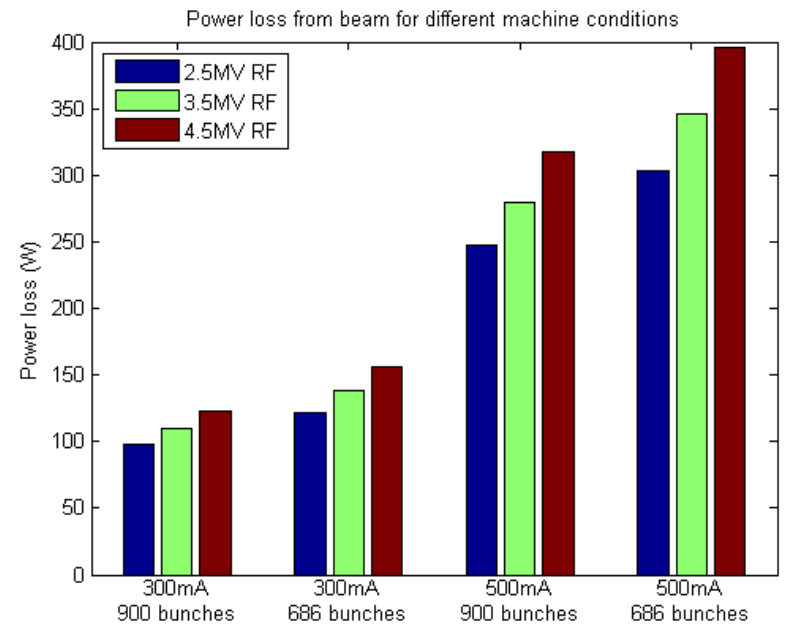
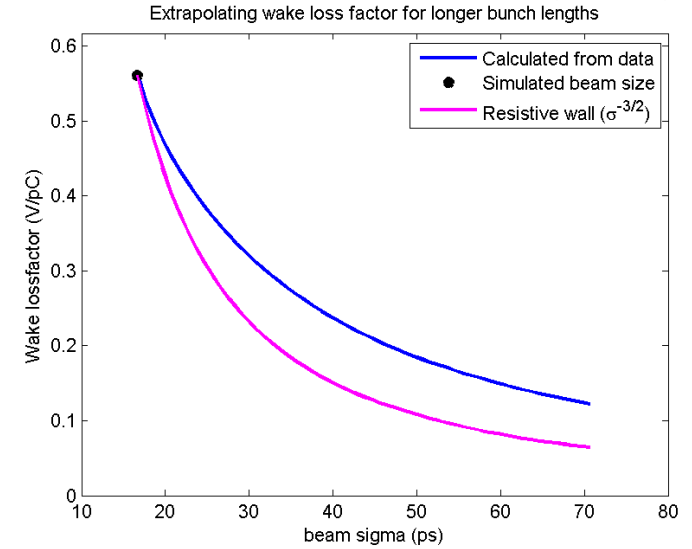
- We can now multiply it with different spectra which allows studies of...
  - multiple bunches
  - Different bunch lengths
  - Machine parameter studies
  - And more...

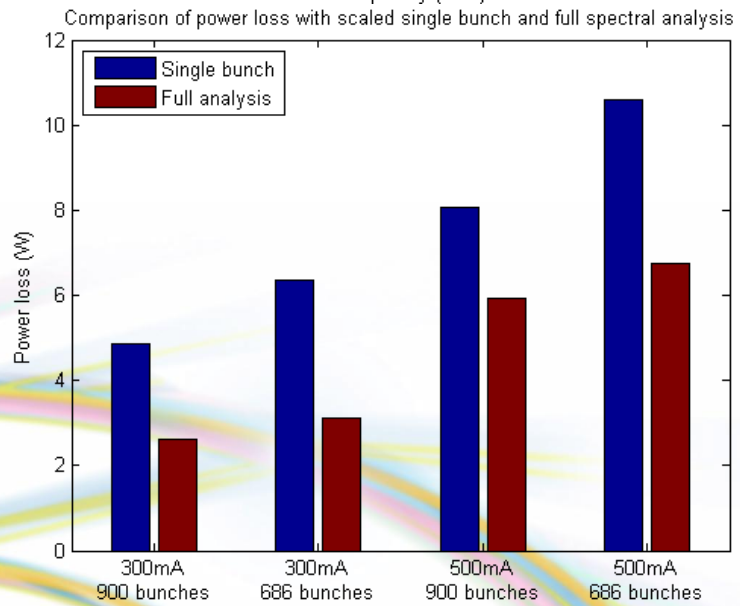
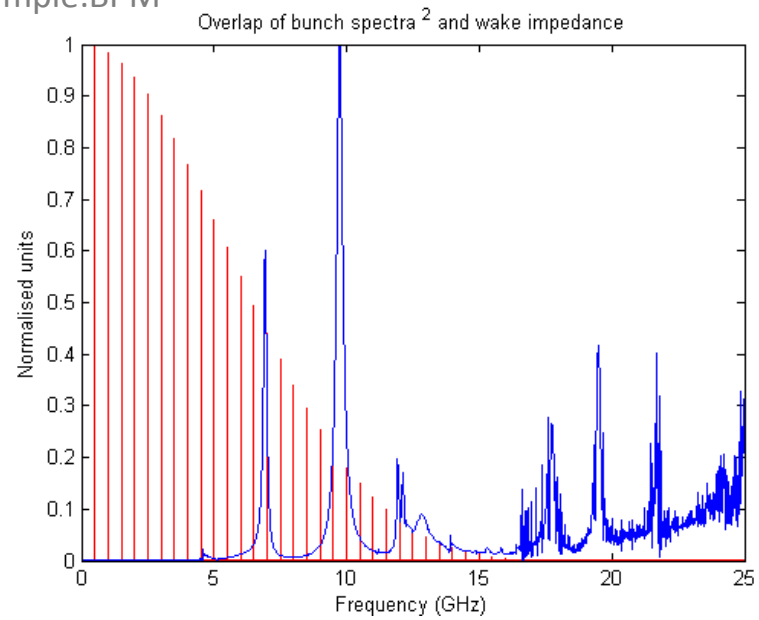
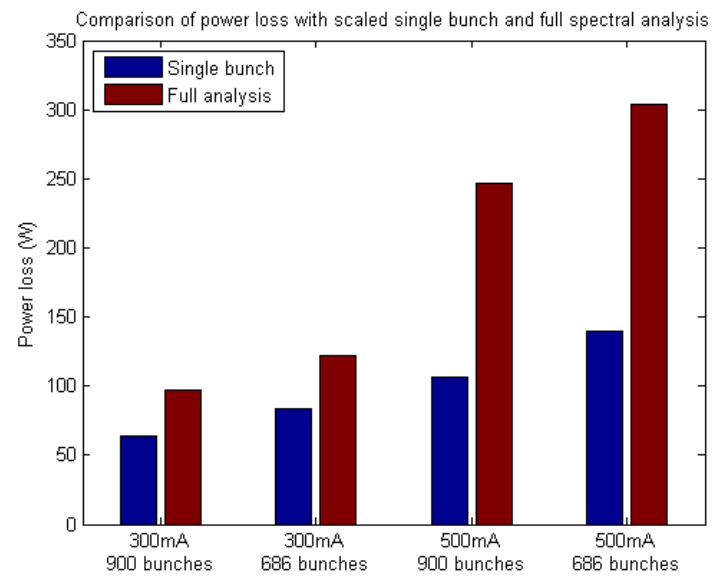
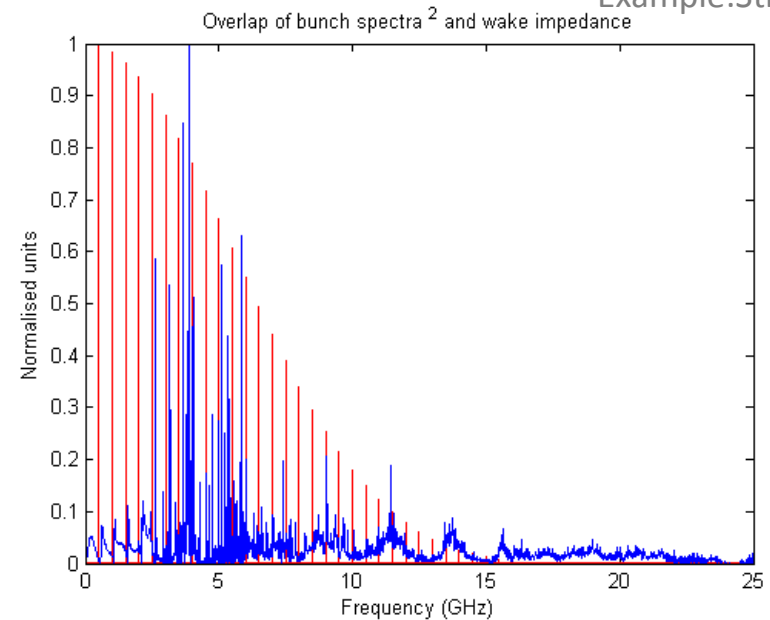


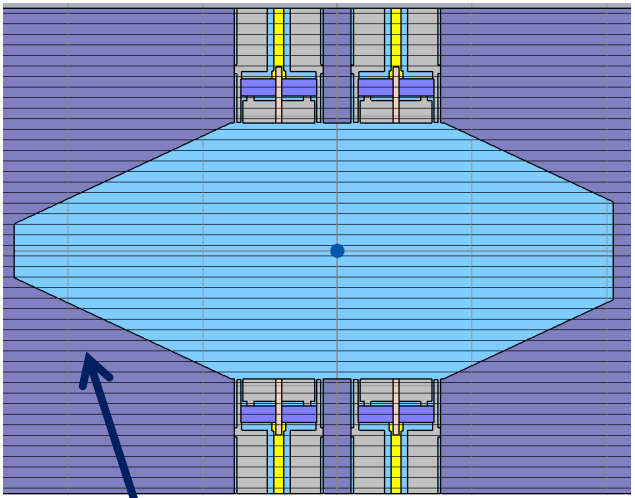
We can only check single bunch variation ... however the multi bunch extension uses the same technique just with different beam spectra.





**Example: BPM**

**Example: Striplines**


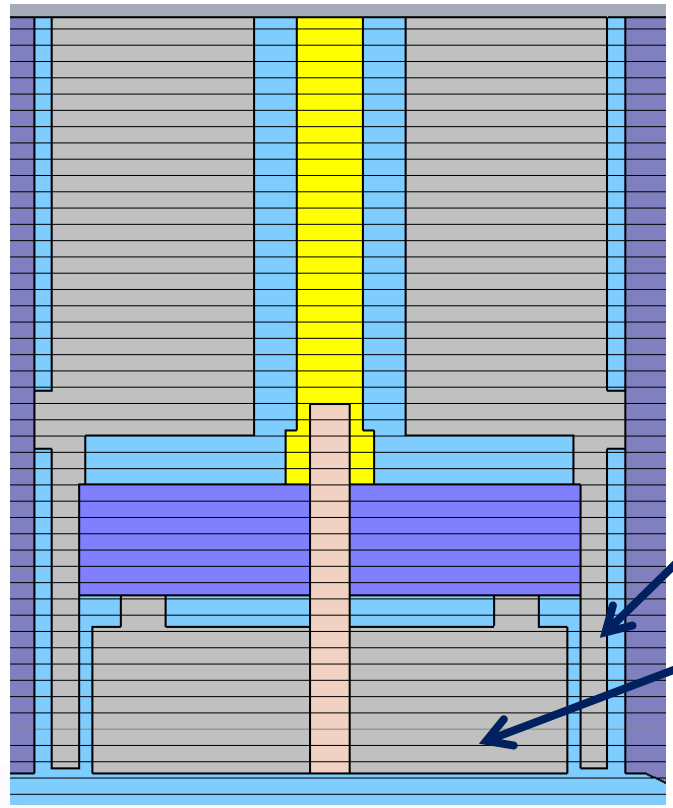
**Example: BPM**

**Example: Striplines**




289mW/629mW

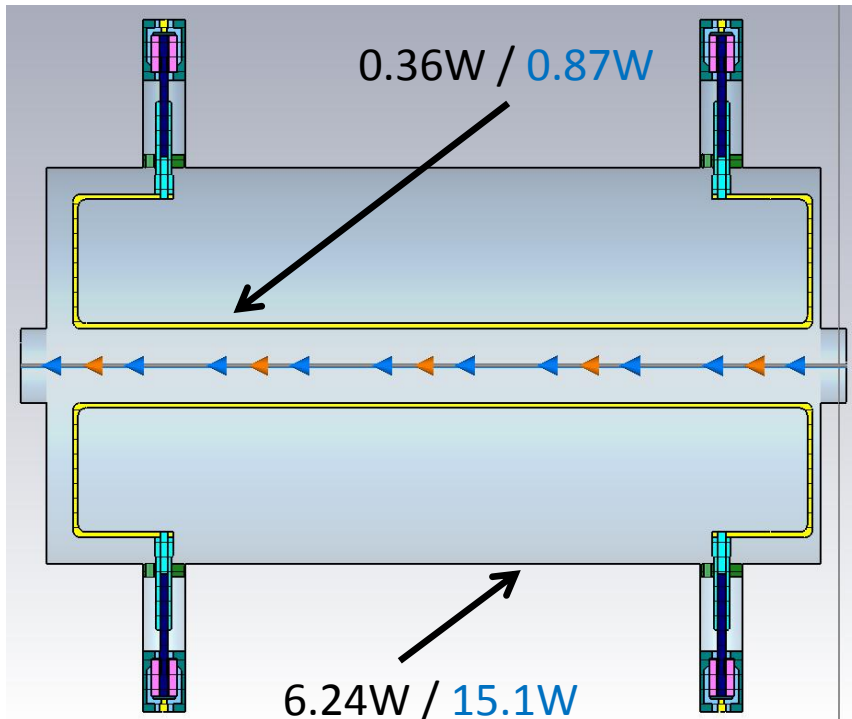
**Power lost into the structure**  
1.7W @ 300mA 686 bunches  
3.7W @ 500mA 686 bunches

Plus 255mW/555mW delocalised loss



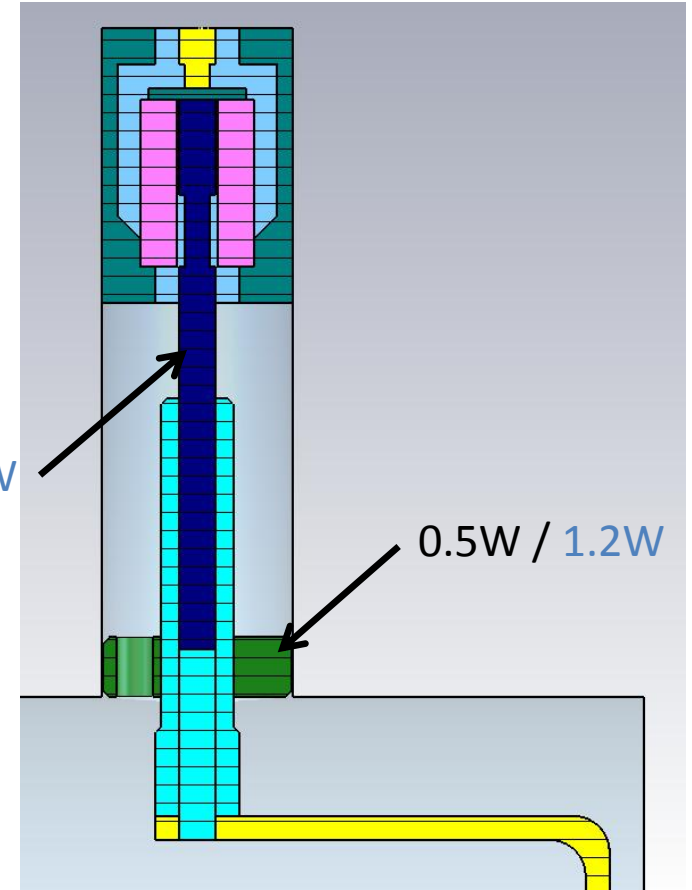
242mW/527mW

38mW/83mW



3W / 7.25W

0.5W / 1.2W



### Power lost into structure

24W @ 300mA 686 bunches

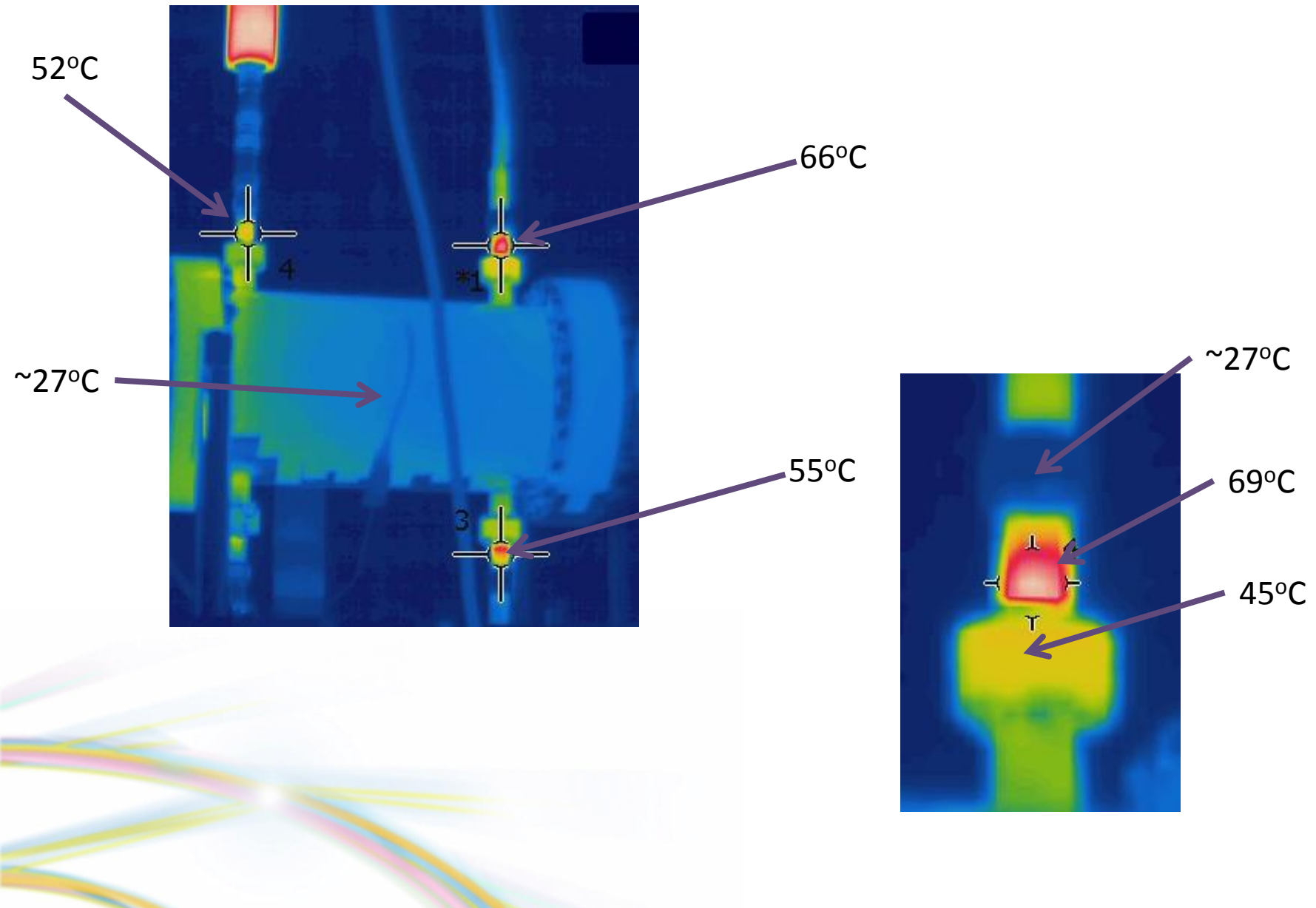
58W @ 500mA 686 bunches

Plus 2.9W / 7W delocalised loss

- For all the currently installed structures tested so far, a large fraction of the 'lost' power is sent down the beam pipe. This will act as an additional heat load on nearby structures.
- Once we have energy accounting per mesh cell in the simulations, most of this will be made redundant.







$$\text{normalised charge} = \frac{\text{Charge distribution data}}{\text{model charge}}$$

$$\text{wake loss distribution} = \text{normalised charge} * \text{Wake Potential}$$

$$\text{wake loss factor} = - \sum_{\text{time}} \text{wake loss distribution} * \text{time step size}$$

$$\text{loss from bunch} = \text{wake loss factor} * \text{model charge}^2$$

- Port signals

$$\text{energy}_{\text{ports,modes}} = \sum_{\text{time}} \text{signals}_{\text{ports,modes}}^2 * \text{time step size}$$

- By using a cumulative sum one can see the evolution of the power deposition (does it all get dumped quickly, or in a more gradual way).

$$\text{fractional loss down the beam pipe} = \frac{\text{port1 energy} + \text{port2 energy}}{\text{loss from beam}}$$



- Zero pad in time domain
- FFT time data

$$\text{bunch spectra} = \frac{FFT(\text{charge distribution})}{\text{number of sample points}}$$

$$\text{FFT of scaled wake potential} = \frac{FFT(\text{Wake Potential} * \text{model charge})}{\text{number of sample points}}$$

$$\text{Wake Impedance} = -\Re\left(\frac{\text{FFT of scaled wake potential}}{\text{bunch spectra}}\right)$$

$$\text{bunch power} = \sum_{\text{frequency}} \left( |\text{bunch spectra}|^2 * \text{Wake Impedance} \right)$$

- Zero the wake impedance when the power in the bunch is small.  
(combats numerical noise).

$$\text{energy for 1 bunch} = \text{bunch power} * \text{simulation time}$$

$$\text{wake loss factor} = \frac{\text{energy for 1 bunch}}{\text{model charge}^2}$$

$$\text{Total power spectrum} = \sum_{\text{port mode}} \sum |FFT(\text{port signals})|^2$$

$$\text{Total power from all ports} = \sum_{\text{time}} |\text{Total power spectrum}|$$



$$\text{bunch charge} = \frac{\text{beam current}}{\frac{1}{\text{pulse gap}} * \frac{\text{fill pattern}}{936}}$$

$$\sigma = 3.87 + 2.41 \left( \frac{\text{beam current}}{\text{fill pattern}} \right)^{0.81} \sqrt{\frac{2.5}{\text{RF Volts}}}$$

## Single pulse

$$\text{pulse} = \frac{1}{\sqrt{2\pi\sigma}} e^{-\frac{\text{Wake Potential timescale}^2}{2\sigma^2}} \text{model charge}$$

## Train

$$\text{pulse} = \sum_{n=1}^N \frac{1}{\sqrt{2\pi\sigma}} e^{-\frac{(\text{Wake Potential timescale} + (\text{gap} * n))^2}{2\sigma^2}} \text{model charge}$$



